# TOWARDS SCALABLE READOUT IC'S FOR SEMICONDUCTOR QUANTUM DOTS

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## 1. INTRODUCTION

- Trade-of between power and sensitivity
  - → higher scalability means lower sensitivity
  - → Develop new multiplexing techniques
- Pay for scalability by sensitivity
  - → OK, if readout fidelity > qubit fidelity

#### TWO OPERATING MODES:

HIGH SPEED, LOW RESOLUTION (OPERATION):

- 1-bit output to detect  $|1\rangle$  and  $|0\rangle$
- Short readout maximizes number of operations
- Read a large number of qubits simultaneously

#### LOW SPEED, HIGH RESOLUTION (TUNING):

- RT ADC for high resolution digitization
- Cryogenic transimpedance amplifier to minimize noise
- Slow time-multiplexed readout

## 2. CONCEPT

## CORRELATED DOUBLE SAMPLING

- Lower temperature → increase of 1/f noise
- Cancelling of low-frequency-noise required

#### **OPERATION**

- 1. Reference sample while quantum dot is an defined state
- 2. quantum dot operations
- 3. If required: spin-to-charge conversion
- 4. Second sample of all quantum dots simultaneously (signal-level depends on final state)
- 5. Compare both samples
- 6. If difference greater than comparator threshold  $\rightarrow$  positive output  $\rightarrow |1\rangle$
- 7. Repeat procedure

# MEASUREMENTS - ANALOG READOUT

LOW SPEED, HIGH RESOLUTION (TUNING):

188 pA RMS (Integrated 10 Hz to 1MHz) Input Referred Noise:

Analog Power: 183 µW 6 K Temperature:

## **MEASUREMENTS – 1-BIT READOUT**

HIGH SPEED, LOW RESOLUTION (OPERATION):

Digital Power: 41 µW

Analog Power: 33.6 µW / SET

Input Referred Noise: 223 pA RMS @ 1µs Sample Time

Temperature: 6 K

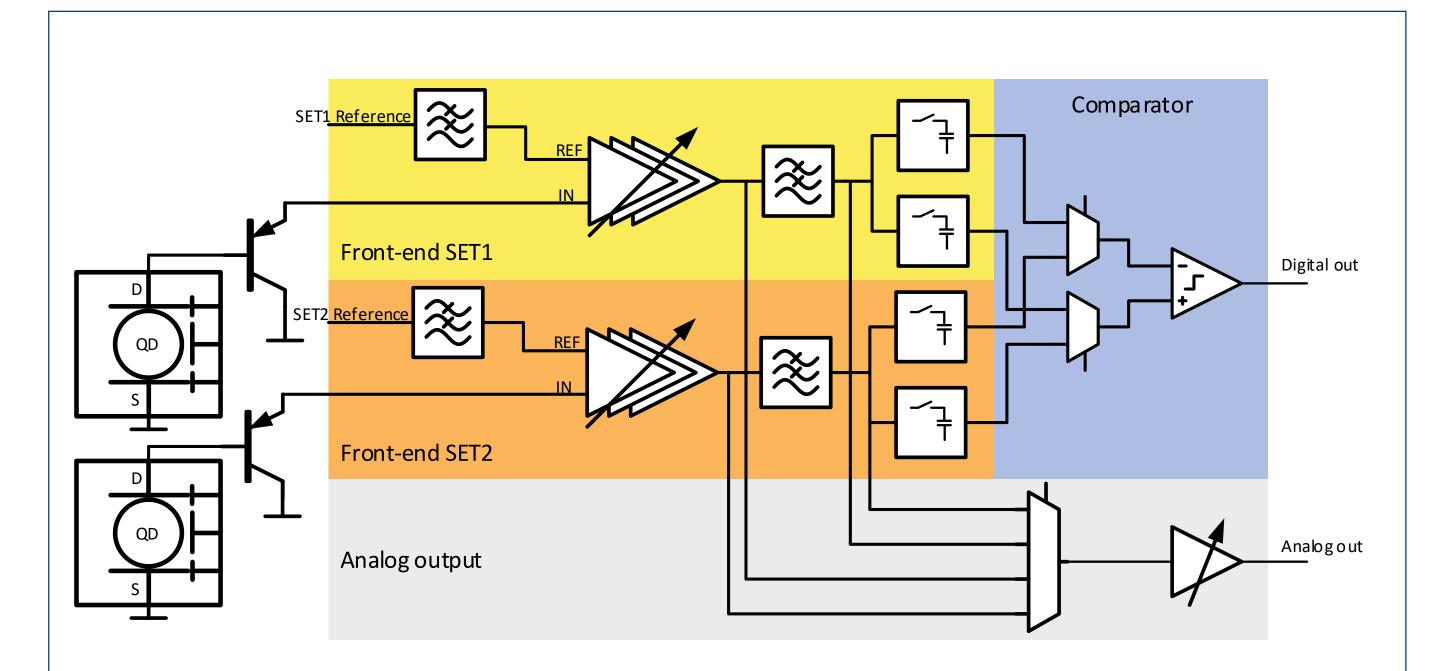
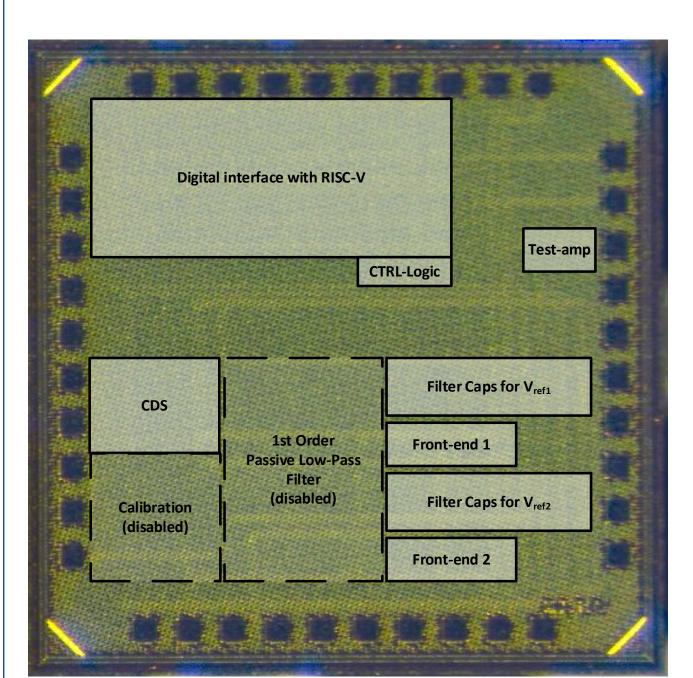
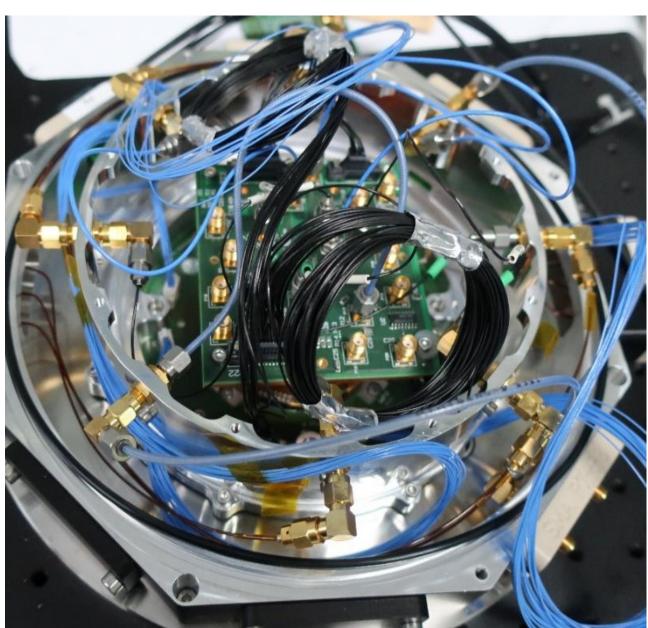


Fig. 1: Simplified block level schematic of QuoccaSET ES1 for readout of two SETs





without bond-wires. Size is 1.25 x 1.25 mm<sup>2</sup>. Quocca.SET at 10K inside attocube's

Fig. 2: DIE-shot of the Quocca.SET IC Fig. 3: Measurement setup for characterizing attoDRY800xs

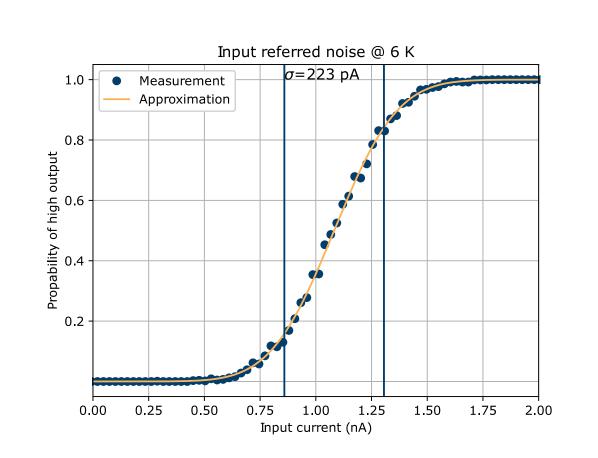
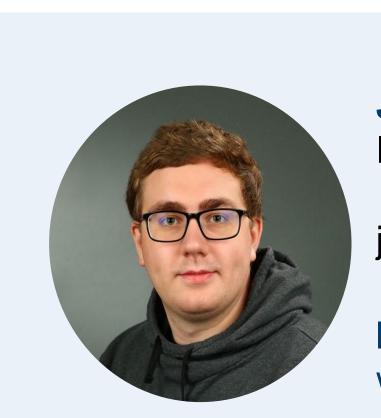


Fig. 4: Measurement of input referred noise at 6 K for 1-bit readout

Fig. 5: Measurement of SET's offset calibration at 6 K



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